Application/Control No. Applicant(s)/Patent Under Reexamination 08/973,424 IEHISA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Phillip Nguyen 2828 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-4,791,631 12-1988 Baumert et al. 372/22 В US-US-C US-D US-Ε F US-G US-Н US-

FOREIGN PATENT DOCUMENTS

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